

Notice of References Cited	Application/Control No. 10/540,936		Applicant(s)/Patent Under Reexamination KUHN ET AL.	
	Examiner David M. Naff		Art Unit 1657	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,696,258	02-2004	Wei et al.	435/7.2
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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